

Search Notes

Application/Control No.

10/061,064

Examiner

Hai Tran

Applicant(s)/Patent under
Reexamination

CRANDALL ET AL.

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search attached	6/20/2005	HT